TOSHIBA Transistor Silicon NPN Triple Diffused Type

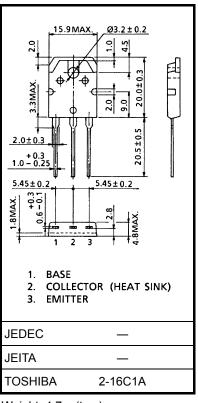
2SC5352

Switching Regulator and High-Voltage Switching Applications High-Speed DC-DC Converter Applications

- Excellent switching times: $t_r = 0.5 \ \mu s \ (max)$, $t_f = 0.3 \ \mu s \ (max)$ (IC = 4 A)
- High breakdown voltage: V_{CEO} = 400 V

Absolute Maximum Ratings (Tc = 25°C)

| Characteristics | | Symbol | Rating | Unit | |
|-----------------------------|-------|------------------|------------|------|--|
| Collector-base voltage | | V _{CBO} | 600 | V | |
| Collector-emitter voltage | | V _{CEO} | 400 | V | |
| Emitter-base voltage | | V _{EBO} | 7 | V | |
| Collector current | DC | ΙC | 10 | A | |
| | Pulse | I _{CP} | 15 | | |
| Base current | | Ι _Β | 5 | А | |
| Collector power dissipation | | De | 80 | W | |
| (Tc = 25°C) | | P _C | 00 | | |
| Junction temperature | | Tj | 150 | °C | |
| Storage temperature range | | T _{stg} | −55 to 150 | °C | |



Weight: 4.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even

www.DataSheet4U.if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

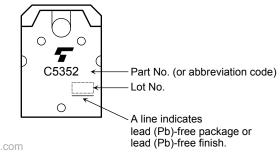
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Unit: mm

Electrical Characteristics (Tc = 25°C)

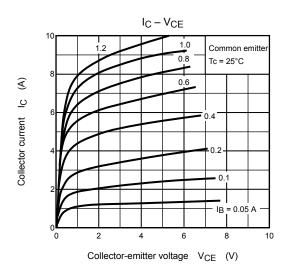
| Chara | acteristics | Symbol | Test Condition | | Тур. | Max | Unit |
|---------------------------------|--------------------|-----------------------|--|-----|------|-----|------|
| Collector cut-off of | current | I _{CBO} | V _{CB} = 480 V, I _E = 0 | _ | _ | 100 | μA |
| Emitter cut-off cu | rrent | I _{EBO} | V _{EB} = 7 V, I _C = 0 | _ | _ | 1 | mA |
| Collector-base br | eakdown voltage | V (BR) CBO | I _C = 1 mA, I _E = 0 | 600 | _ | _ | V |
| Collector-emitter | breakdown voltage | V (BR) CEO | I _C = 10 mA, I _B = 0 | 400 | _ | _ | V |
| DC current gain | | h _{FE} | V _{CE} = 5 V, I _C = 1 A | 20 | _ | _ | |
| Collector-emitter | saturation voltage | V _{CE (sat)} | I _C = 4 A, I _B = 0.5 A | _ | _ | 1.0 | V |
| Base-emitter saturation voltage | | V _{BE (sat)} | I _C = 4 A, I _B = 0.5 A | _ | _ | 1.3 | V |
| Switching time | Rise time | tr | V _{CC} ≈ 200 V | _ | _ | 0.5 | |
| | Storage time | t _{stg} | $20 \ \mu s \qquad I_C \downarrow \stackrel{\bigcirc}{=} \bigcirc \bigcirc$ | _ | _ | 2.0 | μs |
| | Fall time | t _f | I _{B1} = 0.5 A, I _{B2} = −1 A, duty cycle ≤ 1% | _ | _ | 0.3 | |

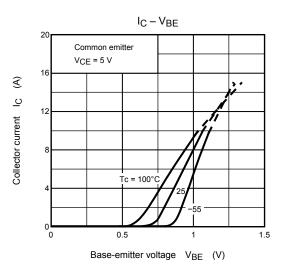
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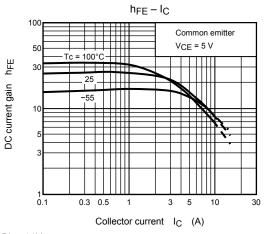


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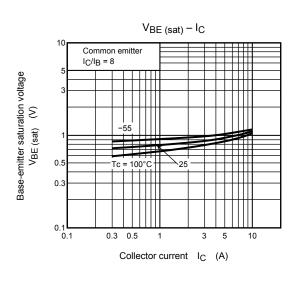
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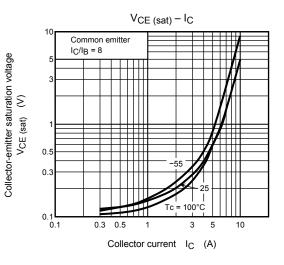


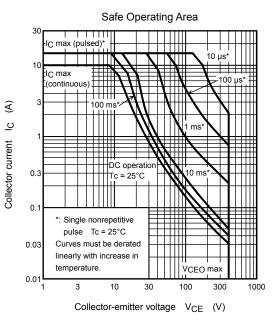












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